Search Notes



| Applicant(s)/Patent Under Reexamination |
|---|
| |

10542027

FREIMUTH ET AL.

Examiner

Art Unit

Jean F Duverne

2839

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------------|---------|----------|
| | Updated search | 6/8/08 | JFD |
| | Updated search | 12/6/08 | JFD |

| SF | ΔR | CH | N | Γ | ES |
|-----|--------|------|---|----------|---------------|
| JL. | \neg | ·UII | | o, | $-\mathbf{u}$ |

| Search Notes | Date | Examiner |
|--------------|------|----------|
| | | |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |

U.S. Patent and Trademark Office Part of Paper No.: 20081206